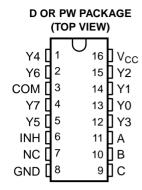
- Qualified for Automotive Applications
- Injection-Current Cross Coupling <1mV/mA (see Figure 1)
- Low Crosstalk Between Switches
- Pin Compatible With CD74HC4051, SN74LV4051A, and CD4051B
- 2-V to 6-V V_{CC} Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II



NC - No internal connection

description/ordering information

This eight-channel CMOS analog multiplexer/demultiplexer is pin compatible with the '4051 function and, additionally, features injection-current effect control, which has excellent value in automotive applications where voltages in excess of normal supply voltages are common.

The injection-current effect control allows signals at disabled analog input channels to exceed the supply voltage without affecting the signal of the enabled analog channel. This eliminates the need for external diode/resistor networks typically used to keep the analog channel signals within the supply-voltage range.

ORDERING INFORMATION^t

T _A	PACKA	AGE [‡]	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	SOIC - D	Tape and reel	SN74HC4851QDRQ1	HC4851Q
-40°C to 125°C	TSSOP - PW	Tape and reel	SN74HC4851QPWRQ1	HC4851Q
	TSSOP - PW	Tape and reel	SN74HC4851QPWRG4Q1	HC4851Q

[†] For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at http://www.ti.com.

FUNCTION TABLE

	INP	UTS		ON
INH	С	В	Α	CHANNEL
L	L	L	L	Y0
L	L	L	Н	Y1
L	L	Н	L	Y2
L	L	Н	Н	Y3
L	Н	L	L	Y4
L	Н	L	Н	Y5
L	Н	Н	L	Y6
L	Н	Н	Н	Y7
Н	Χ	Χ	Х	None

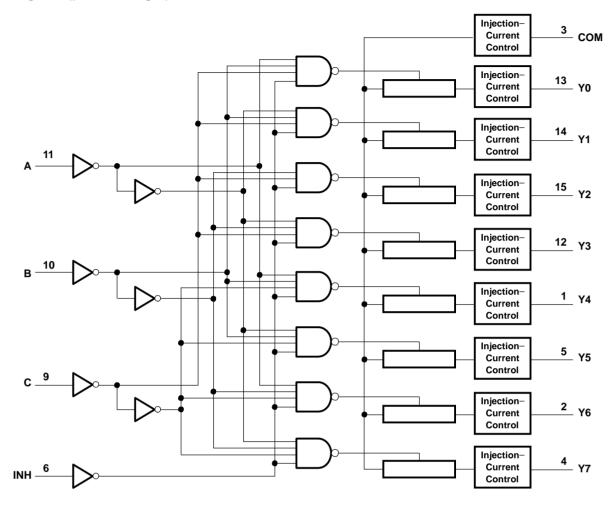


Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



[‡] Package drawings, thermal data, and symbolization are available at http://www.ti.com/packaging.

logic diagram (positive logic)





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)	\cdot . -0.5 V to V _{CC} + 0.5 V
Switch I/O voltage range, V _{IO} (see Notes 1 and 2)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_1 < 0$ or $V_1 > V_{CC}$)	±20 mA
I/O diode current, I_{IOK} (V_{IO} < 0 or V_{IO} > V_{CC})	±20 mA
Switch through current, I_T ($V_{IO} = 0$ to V_{CC})	±25 mA
Continuous current through V _{CC} or GND	±50 mA
Package thermal impedance, θ _{JA} (see Note 3): D package	73°C/W
PW package	108°C/W
Storage temperature range, T _{stq}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. This value is limited to 5.5 V maximum.
 - 3. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 4)

			MIN	MAX	UNIT
V_{CC}	Supply voltage		2	6	V
		V _{CC} = 2 V	1.5		
		V _{CC} = 3 V	2.1		
V_{IH}		V _{CC} = 3.3 V	2.3		V
	control inputs	V _{CC} = 4.5 V	3.15		
		V _{CC} = 6 V	4.2		
		V _{CC} = 2 V		0.5	
		$V_{CC} = 3 V$		0.9	
V_{IL}	Low-level input voltage, control inputs Control input voltage	$V_{CC} = 3.3 \text{ V}$		1	V
	control inputs	V _{CC} = 4.5 V		1.35	
		V _{CC} = 6 V		1.8	
VI	Control input voltage	•	0	V _{CC}	V
V_{IO}	Input/output voltage		0	V _{CC}	V
		V _{CC} = 2 V		1000	
		V _{CC} = 3 V		800	
Δt/Δν	Input transition rise or fall time	$V_{CC} = 3.3 \text{ V}$		700	ns
	Low-level input voltage, control inputs To Control input voltage To Input/output voltage tt/Δν Input transition rise or fall time	$V_{CC} = 4.5 \text{ V}$		500	
		V _{CC} = 6 V		400	
T _A	Operating free-air temperature	•	-40	125	°C

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	DADAMETED	TEGT COMPLETIONS	v	T,	₄ = 25°C	;	UP TO	85°C	UP TO	125°C	
	PARAMETER	TEST CONDITIONS	v _{cc}	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2.V		500	650		670		700	
		$I_T \le 2 \text{ mA},$	3 V		215	280		320		360	
ron	On-state switch resistance	$V_I = V_{CC}$ to GND, $V_{INH} = V_{IL}$	3.3 V		210	270		305		345	Ω
	Switch resistance	(see Figure 5)	4.5 V		160	210		240		270	
			6 V		150	195		220		250	
			2.V		4	13		18		23	
	Difference in	I _T ≤ 2 mA,	3 V		2	10		12		16	
Δr_{on}	on-state resistance	$V_I = V_{CC}/2$,	3.3 V		2	9		12		16	Ω
	between switches	$V_{INH} = V_{IL}$	4.5 V		2	9		12		16	
			6 V		3	10		14		19	
II	Control input current	$V_I = V_{CC}$ or GND	6 V			±0.1		±0.1		±1	μΑ
	Off-state switch leakage current (any one channel)	$V_I = V_{CC}$ or GND, $V_{INH} = V_{IH}$ (see Figure 6)	2./			±0.1		±0.5		±1	
I _{S(off)}	Off-state switch leakage current (common channel)	$V_I = V_{CC}$ or GND, $V_{INH} = V_{IH}$ (see Figure 7)	6 V			±0.2		±2		±4	μΑ
I _{S(on)}	On-state switch leakage current	$V_I = V_{CC}$ or GND, $V_{INH} = V_{IL}$ (see Figure 8)	6 V			±0.1		±0.5		±1	μΑ
I _{CC}	Supply current	$V_I = V_{CC}$ or GND	6 V			2		20		40	μΑ
C _{IC}	Control input capacitance	A, B, C, INH			3.5	10		10		10	pF
C _{IS}	Common terminal capacitance	Switch off			22	40		40		40	pF
Cos	Switch terminal capacitance	Switch off			6.7	15		15		15	pF

injection current coupling specifications, $T_A = -40$ °C to 125°C

	PARAMETER	V _{CC}	TEST CO	NDITIONS	MIN TYP†	MAX	UNIT
		3.3 V		I _I ‡ ≤ 1 mA	0.05	1	
		5 V		1 + ≤ 1 mA	0.1	1	
			$R_S \le 3.9 \text{ k}\Omega$	1 t < 40 ··· A	0.345	5	
\/A	Maximum shift of output voltage of enabled analog	5 V	,	I _I ‡ ≤ 10 mA	0.067	5	mV
V∆ _{out}	channel	3.3 V		1 + 4 4 4	0.05	2	IIIV
		5 V	D- < 20 kO	I _I [‡] ≤ 1 mA	0.11	2	
		3.3 V	R _S ≤ 20 kΩ	I _I ‡ ≤ 10 mA	0.05	20	
		5 V		ıl± ≥ 10 IIIA	0.024	20	



[†] Typical values are measured at T_A = 25°C. ‡ I_I = total current injected into all disabled channels

SN74HC4851-Q1 8-CHANNEL ANALOG MULTIPLEXER/DEMULTIPLEXER WITH INJECTION-CURRENT EFFECT CONTROL

SCLS554C – JANUARY 2004 – REVISED OCTOBER 2012

switching characteristics over recommended operating free-air temperature range, $V_{CC}=2~V,~C_L=50~pF$ (unless otherwise noted) (see Figures 9–14)

	DADAMETED	FROM	то	T	_λ = 25°C	;	UP TO	85°C	UP TO	125°C	unit ns ns
	PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t _{PLH} t _{PHL}	Propagation delay time	COM or Yn	Yn or COM		19.5	30		34		37	ns
t _{PLH} t _{PHL}	Propagation delay time	A, B, C	COM or Yn		23	35		40		45	ns
t _{PZH}	Enable delay time	INH	COM or Yn			95		105		115	ns
t _{PHZ}	Disable delay time	INH	COM or Yn			95		105		115	ns

switching characteristics over recommended operating free-air temperature range, $V_{CC}=3~V,~C_L=50~pF$ (unless otherwise noted) (see Figures 9–14)

	DADAMETER	FROM	то	T,	_λ = 25°C	;	UP TO	85°C	UP TO	125°C	ns ns
	PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t _{PLH} t _{PHL}	Propagation delay time	COM or Yn	Yn or COM		12	17.5		19.5		21.5	ns
t _{PLH} t _{PHL}	Propagation delay time	A, B, C	COM or Yn		13.5	19.5		22		25	ns
t _{PZH}	Enable delay time	INH	COM or Yn			90		100		110	ns
t _{PHZ}	Disable delay time	INH	COM or Yn			90		100		110	ns

switching characteristics over recommended operating free-air temperature range, $V_{CC}=3.3~V,\,C_L=50~pF$ (unless otherwise noted) (see Figures 9–14)

		-									
	DADAMETED	FROM	то	T,	_λ = 25°C	;	UP TO	85°C	UP TO	125°C	LINUT
	PARAMETER	(INPUT)	(OUTPUT)	MIN TYP MAX		MIN	MAX	MIN MAX		UNIT	
t _{PLH} t _{PHL}	Propagation delay time	COM or Yn	Yn or COM		11	16.5		18.5		20.5	ns
t _{PLH} t _{PHL}	Propagation delay time	A, B, C	COM or Yn		12.5	18.5		21		24	ns
t _{PZH}	Enable delay time	INH	COM or Yn			85		95		105	ns
t _{PHZ}	Disable delay time	INH	COM or Yn			85		95		105	ns

SN74HC4851-Q1 8-CHANNEL ANALOG MULTIPLEXER/DEMULTIPLEXER WITH INJECTION-CURRENT EFFECT CONTROL

SCLS554C - JANUARY 2004 - REVISED SEPTEMBER 2012

switching characteristics over recommended operating free-air temperature range, V_{CC} = 4.5 V, C_L = 50 pF (unless otherwise noted) (see Figures 9–14)

	PARAMETER	FROM	то	T,	_λ = 25°C	;	UP TO	85°C	UP TO	125°C	UNIT
	PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t _{PLH}	Propagation delay time	COM or Yn	Yn or COM		8.6	14		15		16	ns
t _{PLH} t _{PHL}	Propagation delay time	A, B, C	COM or Yn		10	16		18		20	ns
t _{PZH}	Enable delay time	INH	COM or Yn			80		90		100	ns
t _{PHZ}	Disable delay time	INH	COM or Yn			80		90		100	ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 6 V, C_L = 50 pF (unless otherwise noted) (see Figures 9–14)

	DADAMETED	FROM	то	T,	_λ = 25°C	;	UP TO	85°C	UP TO	125°C	
	PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t _{PLH} t _{PHL}	Propagation delay time	COM or Yn	Yn or COM		8	12.5		13.5		14.5	ns
t _{PLH} t _{PHL}	Propagation delay time	A, B, C	COM or Yn		9.5	15		17		19	ns
t _{PZH}	Enable delay time	INH	COM or Yn			78		80		80	ns
t _{PHZ}	Disable delay time	INH	COM or Yn			78		80		80	ns

operating characteristics, $T_A = 25^{\circ}C$ (see Figure 15)

	PARAMETER	V _{cc}	TEST CONDITIONS	TYP	UNIT
C .	Davis dissination consistence	3.3 V	No load	32	pF
Cpd	Power dissipation capacitance	5 V	No load	37	рг

APPLICATION INFORMATION

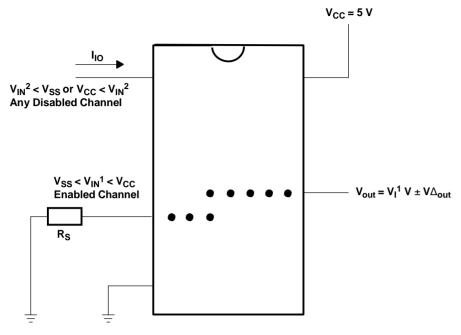


Figure 1. Injection-Current Coupling Specification

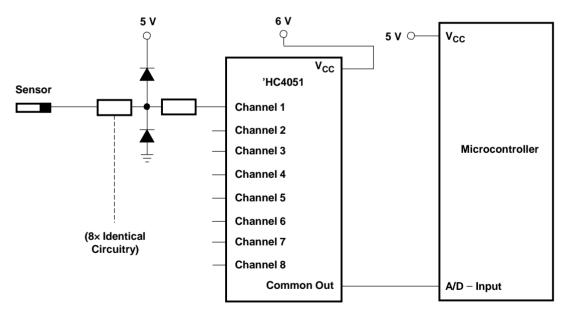


Figure 2. Alternate Solution Requires 32 Passive Components and One Extra 6-V Regulator to Suppress Injection Current Into a Standard 'HC4051 Multiplexer

APPLICATION INFORMATION

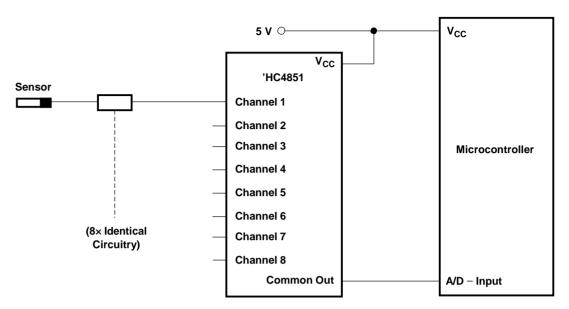


Figure 3. Solution by Applying the 'HC4851 Multiplexer

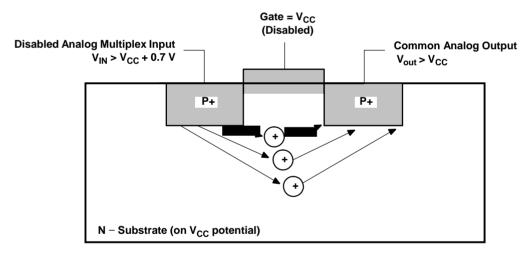


Figure 4. Diagram of Bipolar Coupling Mechanism (Appears if V_{IN} Exceeds V_{CC} , Driving Injection Current Into the Substrate)



PARAMETER MEASUREMENT INFORMATION

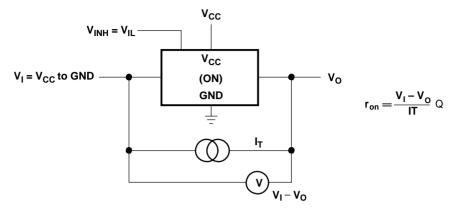


Figure 5. On-State-Resistance Test Circuit

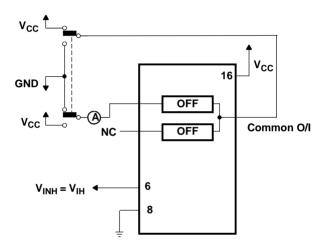


Figure 6. Maximum Off-Channel Leakage Current, Any One Channel, Test Setup

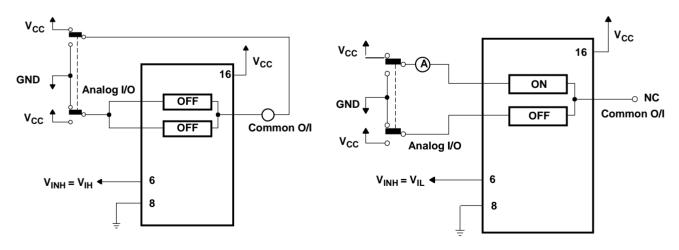


Figure 7. Maximum Off-Channel Leakage Current, Common Channel, Test Setup

Figure 8. Maximum On-Channel Leakage Current, Channel to Channel, Test Setup



PARAMETER MEASUREMENT INFORMATION

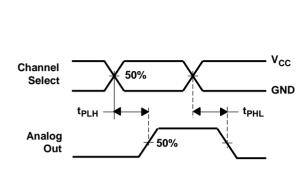


Figure 9. Propagation Delays, Channel Select to Analog Out

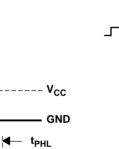
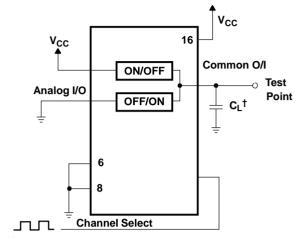


Figure 11. Propagation Delays, Analog In to Analog Out

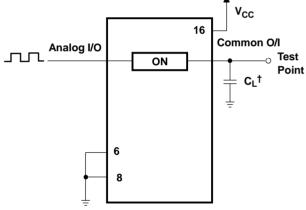
50%

50%



 † Includes all probe and jig capacitance

Figure 10. Propagation-Delay Test Setup, Channel Select to Analog Out



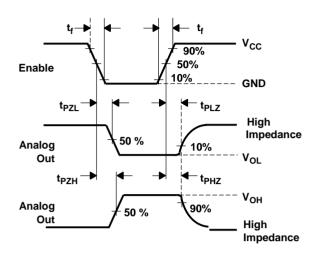
[†] Includes all probe and jig capacitance

Figure 12. Propagation-Delay Test Setup, Analog In to Analog Out

Analog In

Analog Out

PARAMETER MEASUREMENT INFORMATION



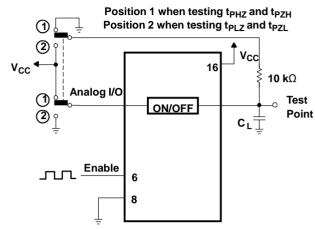


Figure 13. Propagation Delays, Enable to Analog Out

Figure 14. Propagation-Delay Test Setup, Enable to Analog Out

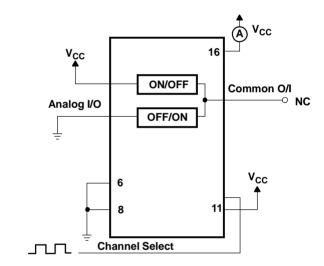


Figure 15. Power-Dissipation Capacitance Test Setup





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PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
SN74HC4851QDRG4Q1	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC4851Q	Samples
SN74HC4851QDRQ1	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC4851Q	Samples
SN74HC4851QPWRG4Q1	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC4851Q	Samples
SN74HC4851QPWRQ1	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC4851Q	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ Only one of markings shown within the brackets will appear on the physical device.

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OTHER QUALIFIED VERSIONS OF SN74HC4851-Q1:

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

PACKAGE MATERIALS INFORMATION

www.ti.com 14-Mar-2013

TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HC4851QPWRG4Q 1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74HC4851QPWRQ1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HC4851QPWRG4Q1	TSSOP	PW	16	2000	367.0	367.0	35.0
SN74HC4851QPWRQ1	TSSOP	PW	16	2000	367.0	367.0	35.0

D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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